High Resolution Temperature Insensitive Interrogation Technique for FBG Sensors

Qiang Wu
*Technological University Dublin*, qiang.wu@dit.ie

Yuliya Semenova
*Dublin Institute of Technology*, yuliya.semenova@dit.ie

An Sun
*Dublin Institute of Technology*

Pengfei Wang
*Dublin Institute of Technology*, pengfei.wang@dit.ie

Gerald Farrell
*Dublin Institute of Technology*, gerald.farrell@dit.ie

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Abstract—In this letter, we propose a high resolution temperature insensitive interrogation technique for FBG sensors where one FBG acts as an edge filter to interrogate a separate FBG sensor. A high resolution of better than 5 µε in strain measurement range from 0 to 1100 µε and the best resolution of better than 1 µε were verified by experiments. An error of only ±2.2 µε is achieved over a temperature range from 15 to 50 °C, indicating that this strain interrogation technique is temperature insensitive. Using an altered system configuration, the temperature was also measured simultaneously with a resolution better than 0.2 °C.

Index Terms—Ratiometric system, FBG, Edge filter

I. INTRODUCTION

Fibre Bragg grating (FBG) based optical sensing technology has been extensively investigated and developed since the first FBG was demonstrated by Hill et al [1-18]. In many applications, the FBG sensor exists in a variable temperature environment. The change in temperature will lead to a centre wavelength shift of the FBG sensor, and hence will lead to measurement errors if the influence of temperature is not taken account of. The conventional way to account for the influence of temperature is to use an additional FBG sensor in the same environment to extract temperature information and hence the other information such as strain, pressure or force can be accurately extracted, with minimal temperature induced errors. The normal way to interrogate two or more FBG sensors is to use an optical spectra analyzer (OSA) or a scanning F-P filter to extract wavelength shifts [19-20]. This makes the interrogation system either high cost or complex. Other interrogation techniques for simultaneously extracting strain and temperature of FBG sensors have been developed [21-22]. However these techniques suffer the same disadvantages of high cost and complexity. Ratiometric wavelength measurement is a simple, high speed and cost effective scheme [23-24]. Recently Miao et al proposed a dynamic temperature compensated interrogation technique by using a tilted FBG as an edge filter in a ratiometric system [25]. This could reduce the complexity of the interrogation system, but the technique suffers at least three disadvantages: (1) the tilted FBG functioning as an edge filter, must be immersed in an index matching gel to get a smooth response - the process for embedding a tilted FBG with an index matching gel in a structure will be more complex compared to conventional embedding of FBG sensors; (2) the refractive index of the index matching gel will change if it exists in an ambient environment for a long time and hence the spectral response of the tilted FBG will change resulting in measurement errors and (3) the ambient temperature cannot be independently measured in such a system configuration.

In this paper, we propose a temperature insensitive interrogation technique for FBG sensors by utilizing two FBGs in a ratiometric system: one FBG functions as an edge filter and one narrow bandwidth FBG functions as a FBG strain sensor. Since both FBGs have similar wavelength shifts for the same temperature change, the measured ratio will be a constant if only the environmental temperature changes. However if strain is applied to the narrow bandwidth FBG sensor, the measured system ratio will change accordingly. Overall this makes the interrogation system temperature insensitive. Moreover an additional edge filter can be connected to the temperature compensating FBG to independently extract temperature information, if required and thus will realize simultaneous measurement both temperature and strain.

II. SYSTEM DESCRIPTION

A schematic diagram of the interrogation system is shown in Fig. 1.

In Fig. 1, FBG 1 functions as an edge filter for FBG 2 and which is also used to compensate temperature induced wavelength shift, while FBG 2 functions as a strain sensor. The broadband optical source passes through FBG 1 first, and then was split into two paths: one goes to the FBG 2 and detected by a photodiode; the other one goes directly to a photodiode acting as a reference arm. The measured ratio $R_1$ is related to the strain.
The normalized spectra of both FBG 1 and FBG 2 are shown in Fig. 2.

![Fig. 2 Spectral response of two FBGs](image)

In Fig. 2, the long wavelength edge of the reflected spectral response of the FBG 1 is used as an edge filter and FBG 2 functions as a conventional FBG stain sensor. As temperature changes, the spectra of both FBG 1 and FBG 2 have similar wavelength shifts and hence the relative wavelength shift between them is very small. In this case the level of optical power reflected from the FBG 1 and passed through the splitter and reflected from the FBG 2 will change. The strain can be easily extracted by monitoring the ratio variations.

Assuming the optical power density of the broadband optical source is 1, the ratio $R_i$ of the system can be expressed as

$$R_i = 10 \log_{10} \left[ \frac{\int G_{i1}(\lambda)G_{21}(\lambda)d\lambda}{\int G_{i1}(\lambda)d\lambda} \right]$$  (1)

Where $G_{i1}(\lambda)$ and $\lambda_i$ are the transmission response and the centre wavelength of FBG 1 respectively, while $G_{21}(\lambda)$ and $\lambda_2$ are the transmission response and the centre wavelength of FBG 2 respectively.

Assuming the initial centre wavelengths of FBG 1 and FBG 2 are $\lambda_{i1}$ and $\lambda_{i2}$, and the temperature and strain induced centre wavelength shifts are $\Delta \lambda_i$ and $\Delta \lambda_s$ respectively, Eq. (1) can be expressed as

$$R_i = 10 \log_{10} \left[ \frac{\int G_{i1}(\lambda)G_{21}(\lambda)d\lambda}{\int G_{i1}(\lambda)d\lambda} \right]$$  (2)

For FBGs, once the temperature changes, the central wavelength of the reflected spectrum will shift, however the shape of the spectrum won’t change. In this case the integral of spectrum remains unchanged and we have

$$\int G_{i1}(\lambda)d\lambda = \int G_{i1}(\lambda)d\lambda$$  (3)

Eq. (2) can be rewritten as

$$R_i = 10 \log_{10} \left[ \frac{\int G_{i1}(\lambda)G_{21}(\lambda+d\lambda)d\lambda}{\int G_{i1}(\lambda)d\lambda} \right]$$  (4)

Eq. (4) contains no temperature induced wavelength shift term $\Delta \lambda_i$, so only strain induced wavelength shift $\Delta \lambda_s$ contributes to $R_i$, so that $R_i$ is temperature insensitive.

### III. EXPERIMENTAL RESULTS

As an example, we carried out experimental investigations by applying strain to FBG 2. The spectral responses of the two FBGs used in our experiments are shown in Fig. 2.

The relative wavelength shifts of the two FBGs vs. temperature, measured by an OSA with a resolution 0.01 nm is shown in Fig. 3(a-b).

![Fig. 3 Measured (a) wavelength shifts and (b) relative wavelength shifts of FBG 1 and FBG 2 vs. temperature](image)

In Fig. 3(a), the square and circle are the measured temperature induced wavelength shifts of FBG 1 and FBG 2 respectively, and the inverse triangle in Fig. 3(b) is temperature induced relative wavelength shifts between FBG 1 and FBG 2. It shows that both FBGs have similar wavelength shifts and the maximum difference is 6 pm at temperature range from 15 °C.
to 50 °C. The discontinuity between 40 °C and 45 °C is due to the limited resolution of the OSA which is 10 pm and the measured temperature induced wavelength shifts difference between FBG 1 and FBG 2 is 6 pm.

Further experiments were carried out by applying strain to FBG 2 at room temperature. The measured ratio vs. strain was shown in Fig. 4 (bottom axis).

![Figure 4 Measured ratio R₁ vs. strain at room temperature and measured ratio R₁ vs. temperature at fixed strain](image)

Figure 4 shows that as strain increases from 0 to 1100 με, the measured ratio $R_i$ decreases monotonically and the rate of decrease (corresponding to the slope) increases firstly and then decreases. To investigate the influence of temperature on the system ratio variations, experiments were carried out by increasing the temperature from 15 to 50 °C at a fixed strain of 320 με. The ratio response of $R_i$ is shown in Fig. 4 (top axis).

Our calculations show that the ratio variation of $R_i$ is only ±0.15 dB for temperature range from 15 to 50 °C, which corresponds to strain variation of ±2.2 με or ±0.063 με/°C. This result indicates that the FBG strain sensor is temperature insensitive, which matches well with Eq. (5).

To illustrate the resolution of this system, an incremental step change of 50 με and 2 με are applied to the FBG 2 sensor. The measured ratio variations $R_i$ vs. time are shown in Fig. 5(a-b).

![Figure 5 Measured ratio $R_i$ variations vs. time with (a) step change 50 με and (b) step change of 2 με from 200 με to 220 με](image)

Figure 5(a) shows that there is minimum ratio change step at strain range from 0 to 1100 με and from 1050 to 1100 με. The maximum peak-to-peak ratio variation is 0.014 dB and the minimum discrimination over the whole strain range from 0 to 1100 με is 0.16 dB for a step change of 50 με. Hence we can estimate the worst case resolution of this system as at least 5 με over the whole strain measurement range from 0 to 1100 με. Figure 5(b) shows the effect of small strain step change of 2 με from 200 to 220 με, which indicates that the resolution over certain strain ranges is better than 1 με.

**IV. ADAPTATION OF THE SYSTEM TO MEASURE TEMPERATURE AND STRAIN SIMULTANEOUSLY**

It has been shown that the system presented above can be used for measurement of strain with dynamic temperature compensation. If we want to measure both strain and temperature simultaneously, an additional edge filter can be added to the system to measure temperature as shown in Fig. 6.

In Fig. 6, FBG 1 functions as an edge filter which used to compensate temperature induced wavelength shift and FBG 2 functions as a strain sensor. The broadband optical source passes through FBG 1 first, and then was split into three paths: one goes to the FBG 2 and detected by a photodiode; one goes directly to a photodiode acting as a reference arm; the last one passes through a second edge filter (in this case it is a thin film edge filter, other types of edge filter could be used) and finally is detected by a photodiode. The measured ratios $R_i$ and $R_2$ are related to the strain and temperature respectively.

![Fig. 6 Schematic diagram for simultaneous measurements of strain and temperature](image)
Since the system configuration is similar to that in Fig. 1, experiments were only carried out for $R_2$. Figure 7 shows the ratio change as the temperature increases from 15 to 50 °C. It is noted that the curve is normalized to a common ratio value of 0 dB at 15 °C.

![Normalized ratio vs. temperature](image.png)

**Figure 7** Measured ratio $R_2$ variations vs. temperature

Figure 7 shows that as temperature increase from 15 to 50 °C, the measured ratio of $R_2$ increases monotonically and can be used to extract temperature information. The discrimination from 15 to 50 °C is 2.29 dB and hence the average temperature ratio change is 0.065 dB/°C. Assuming the minimum resolution of the photodiode is 0.01 dB, then the temperature resolution of this system is better than 0.2 °C.

V. CONCLUSION

A high resolution temperature insensitive interrogation technique for FBG sensors is proposed. This technique uses two FBGs: one functions as an edge filter to demodulate another FBG which functions as a strain sensor. Experimental results show that this technique has a high resolution of at least 5 µε for strain measurement from 0 to 1100 µε and that the best resolution can be better than 1 µε for certain strain ranges. Experiments verified that this technique is temperature insensitive with only error of ±0.063 µε/°C over a temperature range from 15 to 50 °C. By adding an additional edge filter and photodiode, the temperature can be measured simultaneously. Experimentally the resolution achieved is better than 0.2 °C.

REFERENCES